

High Speed Buffer 100MHz Video Line Driver



CLM4103/CLM4303

FEATURES

- Improved Second Source to Elantec EL2002
- Slew Rate 1200V/μs
- Wide Bandwidth..... 100MHz
- Output current 230mA
- High Input Impedance..... 2MΩ
- No Oscillations with Capacitive Loads
- 5V to ±15V Operation Guaranteed
- Current and Thermal Limiting
- Fully Specified to Drive 50Ω Lines

APPLICATIONS

- Op Amp Booster
- Video DAC Buffer
- Coax Cable Driver
- Line Driving
- Radar
- Sonar

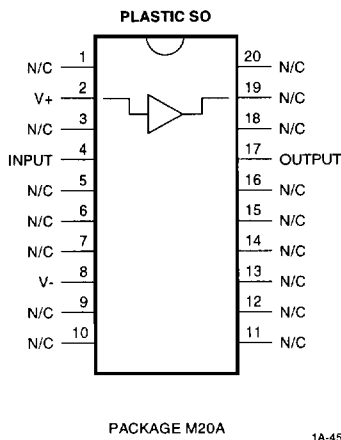
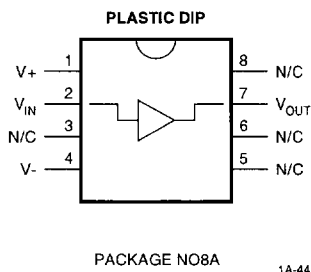
GENERAL DESCRIPTION

The CLM4103 family are high speed unity gain buffers that slew at 1200V/μs, having a small signal bandwidth of 100MHz, and capable of providing a continuous output current of ±150mA. They are monolithic ICs which are pin to pin compatible with the EL2003 and HA5002.

ORDERING INFORMATION

Part	Package	Temperature Range
CLM4103 N	Plastic P Dip 8 Lead	-40°C to +85°C
CLM4303 N	Plastic P Dip 8 Lead	-40°C to +85°C
CLM4103 M	SOIC 20 Lead	-25°C to +70°C
CLM4303 M	SOIC 20 Lead	-25°C to +70°C

CONNECTION DIAGRAMS



ABSOLUTE MAXIMUM RATINGS (Note 1)

Supply Voltage.....	±18 or 36V
Input Voltage.....	±V _{supply}
Short Circuit to GND.....	Continuous
ESD Tolerance (Note 4).....	±2000V
Thermal Resistance (θ _{JA}) (Note 7)	
N Package.....	50°C/W
M Package.....	60°C/W

Storage Temperature Range.....	-65°C to +150°C
Lead Temperature (Soldering 10 seconds).....	260°C

DC ELECTRICAL CHARACTERISTICS

The following specifications apply for Supply Voltage = ±15V, V_{CM} = 0, R_L ≥ 100kΩ and R_S = 50Ω unless otherwise noted.
Boldface limits apply for T_A = T_J = T_{MIN} to T_{MAX}; all other limits T_A = T_J = 25°C.

SYMBOL	CHARACTERISTICS	TYP	CLM4103	CLM4303	UNITS	CONDITIONS
			Limit (Note 5)	Limit (Note 5)		
A _{V1}	Voltage Gain 1	0.990	0.980 0.970	0.970 0.970	V/V Min	R _L = 1kΩ, V _{IN} = ±12V
A _{V2}	Voltage Gain 2	0.900	0.850 0.800	0.830 0.800		R _L = 50Ω, V _{IN} = ±6V
A _{V3}	Voltage Gain 3	0.850	0.830 0.790	0.820 0.790		R _L = 50Ω, V _{sup} = ±5V V _{IN} = ±3V
V _{OS}	Offset Voltage	15	25 54	35 50	mV Max	
I _B	Input Bias Current	1	10 20	20 30	μA Max	R _S = 10kΩ,
R _{IN}	Input Resistance	5	1	1	MΩ Min	R _L = 100Ω
C _{IN}	Input Capacitance	3.5			pF	
R _O	Output Resistance	7	10 12	10 12	Ω Max	V _{IN} = ±2V, R _L = 50Ω
I _S	Supply Current	15	15 20	15 20	mA Max	R _L = ∞
V _{O1}	Output Swing 1	13.5	13.0 12.5	13.0 12.5	±V Min	R _L = 1k, V _{IN} = ±14V
V _{O2}	Output Swing 2	11.3	10.5 10.0	10.5 10.0		R _L = 100Ω, V _{IN} = ±12V
V _{O3}	Output Swing 3	12	11 9	10 9		R _L = 50Ω, V _{IN} = ±14V
PSSR	Power Supply Rejection Ratio	80	60 5	60 50	dB Min	V [±] = ±5V to ±15V
I _{OUT}	Output Current	±230	150	150	mA Min	

AC ELECTRICAL CHARACTERISTICS

The following specifications apply for Supply Voltage = $\pm 15V$, $V_{CM} = 0$, $R_L \geq 100k\Omega$ and $R_S = 50\Omega$ unless otherwise noted. **Boldface** limits apply for $T_A = T_J = T_{MIN}$ to T_{MAX} ; all other limits $T_A = T_J = 25^\circ C$.

SYMBOL	CHARACTERISTICS	TYP	CLM4103	CLM4303	UNITS	CONDITIONS
			Limit (Note 5)	Limit (Note 5)		
SR ₁	Slew Rate 1	1200	600	600	V/ μ s	$V_{IN} = \pm 10V$, $R_L = 1k\Omega$ (Note 2)
SR ₂	Slew Rate 2	800	400	400	V/ μ s	$V_{IN} = \pm 5V$, $R_L = 50\Omega$
t _r , t _f	Rise Time Fall Time	7.0			ns	$R_L = 50\Omega$, $C_L \leq 10pF$ $V_O = 100mV_{PP}$
t _{pd}	Propagation Delay Time	4.0			ns	$R_L = 50\Omega$, $C_L \leq 10pF$ $V_O = 100mV_{PP}$
THD	Distortion @ 1KHz	0.2	1	1	%	$V_{IN} = \pm 4V_{rms}$, $R_L = 50\Omega$

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. DC and AC electrical specifications do not apply when operating the device beyond its rated operating conditions.

Note 2: Slew rate is measured with a $\pm 10V$ input pulse and 50Ω source impedance at $25^\circ C$. For accurate measurements, the input slew rate should be at least $1700V/\mu s$.

Note 3: The test circuit consists of the human body model of $120pF$ in series with 1500Ω .

Note 4: The maximum power dissipation is a function of $T_{J(max)}$, θ_{JA} and T_A . The maximum allowable power dissipation at any ambient temperature is $P_D = (T_{J(max)} - T_A)/\theta_{JA}$.

Note 5: Limits are guaranteed by testing, correlation or periodic characterization.

Note 6: For M & N package, θ_{JA} is measured by soldering the unit directly on a printed circuit board and V pins are connected to 2 square inches of 2 oz copper.

